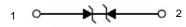


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Transient Voltage Suppressor

Micro-Packaged Diode for ESD Protection

The XESD2FD3V3C Series is designed to protect voltage sensitive components from damage or latch-up due to ESD. Excellent clamping capability, low leakage, and fast response time provide best in class protection on designs that are exposed to ESD for board level. Because of its small size and bi-directional design, it is ideal for use in cellular phones, MP3 players, and portable applications that require audio line protection.



DFN1006-2L

Specification Features

- Small Body Outline Dimensions:
 - nom 0.039" x 0.024" (1.0x0.6 mm)
- Low Body Height: nom 0.019" (0.5 mm)
- Low Capacitance 12 pF
- Low Clamping Voltage
- Reverse Working (Stand-off) Voltage: 3.3 V
- Low Leakage
- Response Time is Typically < 1 ns
- IEC61000-4-2 Level 4 ESD Protection
- This is a Pb-Free Device

Mechanical Characteristics:

- CASE: Void-free, transfer-molded, thermosetting plastic Epoxy Meets UL 94 V-0
- LEAD FINISH: NiPdAu
- MOUNTING POSITION: Any
- QUALIFIED MAX REFLOW TEMPERATURE: 260°C
- Device Meets MSL 1 Requirements
- RoHS/WEEE Compliant
- Marking: Marking code

Applications

- Cellular Handsets & Accessories
- Personal Digital Assistants (PDAs)
- Notebooks & Handhelds
- Portable Instrumentation
- Digital Cameras
- Peripherals
- MP3 Players



Maximum Ratings

Rating	Symbol	Value	Unit
IEC 61000-4-2 (ESD) Contact		±30	kV
Peak Power Per 8 x 20µs Waveform	P _{PK}	100	W
Total Power Dissipation on FR-5 [®] Board @ TA = 25°C	P_{D}	300	mW
Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Lead Solder Temperature - Maximum (10 Second Duration)	TL	260	ç

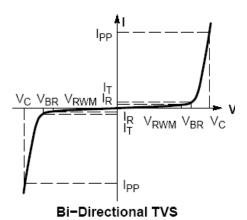
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Note1: FR-5 =1.0*0.75*0.062inch (25.4*19.05*1.58mm).

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise noted.})$

Symbol	Parameter
I _{PP}	Maximum Reverse Peak Pulse Current
V _C	Clamping Voltage @ IPP
V_{RWM}	Working Peak Reverse Voltage
I _R	Maximum Reverse Leakage Current @ V _{RWM}
I _T	Test Current
V_{BR}	Breakdown Voltage @ I _T
P_{PK}	Peak Power Dissipation
С	Max. Capacitance @ $V_R = 0$ and freq.=1 MHz



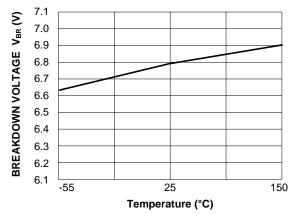
 \textbf{V}_{RWM} Max. V_C (V) I_R (μA) @ V_{RWM} **V**_{BR} (V) @ **I**_T I_{T} C **Device** Mark $@ I_{PP}^{2} = 1A$ (mA) (pF) (V) Тур. Max. Min. Тур. Max. XESD2FD3V3C 5C 3.3 0.05 1 6.5 6.8/7.6 8 9.8 12 1

Note2: Surge current wave form per figure 3.

Datasheet Page 2 of 4



TYPICAL CHARACTERISTICS



110 LEAKAGE CURRENT IR (nA) 100 90 80 70 60 50 40 30 20 10 -55 25 150 Temperature (°C)

Figure 1: Typical Breakdown Voltage versus Temperature

Figure 2: Typical Leakage Current versus Temperature

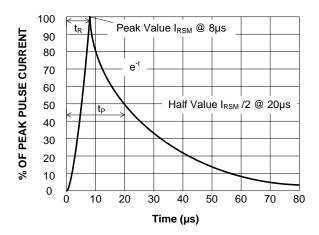
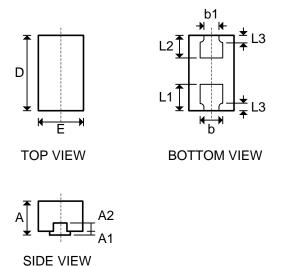


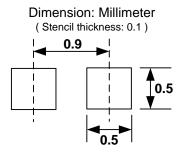
Figure 3: 8/20µs Pulse Wave Form



PACKAGE OUTLINE DIMENSIONS

DFN1006-2L





Soldering Footprint

Symbol	Dimensions in mm			
Symbol	MIN.	NOM.	MAX.	
А	0.450	0.500	0.550	
A1	0.000	-	0.050	
A2	0.150REF.			
D	0.950	1.000	1.050	
Е	0.550	0.600	0.650	
b	0.250	0.300	0.350	
b1	0.150	0.200	0.250	
L1	0.300	0.350	0.400	
L2	0.250	0.300	0.350	
L3	0.100REF.			